

**Search Notes**

Application/Control No.

10/792,292

Examiner

Adrian L. Kennedy

Applicant(s)/Patent under  
Reexamination

FUJII ET AL.

Art Unit

2121

**SEARCHED**

Class	Subclass	Date	Examiner
706	59	8/5/2006	AK
706	8	8/5/2006	AK
706	50	8/5/2006	AK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS Search	8/17/2006	AK
IEEE NPL Search	8/21/2006	AK
ACM NPL Search	8/21/2006	AK
EAST Keyword	8/17/2006	AK
EAST Keyword	8/18/2006	AK
EAST Keyword	8/21/2006	AK